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CONFIRMATION NO. 8779

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SERIAL NUMBER 09/991,511	FILING DATE 06/27/2001 RULE	CLASS 438	GROUP ART UNIT 2812	ATTORNEY DOCKET NO. 010819
<b>APPLICANTS</b> Mamoru Nakasugi, Kanagawa, JAPAN; Nobuharu Noji, Kanagawa, JAPAN; Tetsu Satake, Kanagawa, JAPAN; Masahiro Matakayama, Kanagawa, JAPAN; Toshihumi Kimba, Kanagawa, JAPAN; Hiroshi Sobutawa, Kanagawa, JAPAN; Shoji Yoshikawa, Tokyo, JAPAN; Takeshi Murakami, Tokyo, JAPAN; Kenji Watanabe, Kanagawa, JAPAN; Tsutomu Kariwato, Kanagawa, JAPAN; Shin Oowada, Kanagawa, JAPAN; Mutsumi Saito, Kanagawa, JAPAN; Yutichiro Yamazaki, Tokyo, JAPAN; Takamitsu Negai, Kanagawa, JAPAN; Ichiro Nagahama, Kanagawa, JAPAN;				
* CONTINUING DATA none				
* FOREIGN APPLICATIONS <ul style="list-style-type: none"> <li>JAPAN 2000-183104 08/27/2000</li> <li>JAPAN 2000-229101 07/28/2000</li> <li>JAPAN 2000-335934 11/02/2000</li> <li>JAPAN 2001-11218 01/19/2001</li> <li>JAPAN 2001-31901 02/08/2001</li> <li>JAPAN 2001-31808 02/08/2001</li> <li>JAPAN 2001-33593 02/09/2001</li> <li>JAPAN 2001-35089 02/13/2001</li> <li>JAPAN 2001-158862 05/28/2001</li> <li>JAPAN 2001-182041 05/30/2001</li> <li>JAPAN 2001-189304 06/22/2001</li> </ul>				
IF REQUIRED, FOREIGN FILING LICENSE GRANTED 08/28/2001				
Foreign Priority claimed <input checked="" type="checkbox"/> yes <input type="checkbox"/> no 35 USC 119 (a)-(d) conditions <input type="checkbox"/> yes <input type="checkbox"/> no <input type="checkbox"/> other Filed and Acknowledged Address 23850	STATE OR COUNTRY JAPAN	SHEETS DRAWING 50	TOTAL CLAIMS 60	INDEPENDENT CLAIMS 13
TITLE Inspection system by charged particle beam and method of manufacturing devices using the system				

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